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Suppression of photoconductivity by magnetic field in epitaxial manganite thin films

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The erasure of photoinduced resistance (PR) by the magnetic field was investigated in manganite films. The PR was significantly suppressed when a magnetic field was introduced at low temperature. The decrease (or increase) of PR with increment of magnetic field was observed in ferromagnetic (or paramagnetic) phases of films, respectively. Our results are suggested to be the coaction of two effects under magnetic fields: (i) the reorientation of domains and spin directions of photoexcited carriers and (ii) electrons trapped around oxygen vacancies released and recombined with majority carriers in films. The interplay of the external fields is a good demonstration of the strong coupling between spins and charges in colossal magnetoresistance materials. © 2012 American Institute of Physics. [doi:10.1063/1.3683551]

The doped manganite oxides has been intensively studied due to its rich physical properties and the potential in device applications. The features of the magnetic and transport properties of this system can be well understood in the framework of the double-exchange (DE) mechanism and electron-phonon interaction due to the Jahn-Teller (J-T) distortion.1,2 One of the interesting properties in manganites is that they are sensitive to the external fields and factors, such as magnetic field,3 electric field,4 strain,5,6 and light.7–13 In the past decades, photoinduced effects, such as photoinduced insulator-to-metal (IM) transition,7 transient and persistent photoconductivity,7,8 and photoinduced demagnetization,7,9–13 had been widely studied. Among the photoinduced effects, the photoinduced demagnetization effect in the doped manganites is a fascinating phenomenon. It is believed that the photoexcited e_g carriers are expected to significantly affect the magnetic interaction via modifying the t_2g spin ordering. Meanwhile, the transport property of manganites is strongly influenced by the photoinduced demagnetization effect at low temperature. In La_{0.7}Ca_{0.3}MnO_3 films, the increase of resistance under laser illumination was observed in ferromagnetic phase, indicating that the photoexcited carriers changed the antiferromagnetic/ferromagnetic phase balance, favoring the insulating antiferromagnetic phase.8,9,12,13 In previous works, we reported the strain-mediated photoinduced demagnetization effect in manganites via external applied electric field on the ferroelectric substrates.6 However, the related physical mechanism is not very clear so far. In this letter, we studied the photoinduced change of the resistance (PR) of La_{0.8}Ca_{0.2}MnO_3 (LCMO) thin films under the external magnetic field. The results show that the proportion of PR is weakened by the external magnetic field. The mechanism of such behavior was discussed in detail. The results provide us some insight into the nature of physical properties of manganites under irradiation of light.

The LCMO thin films with thickness of ~150 nm were epitaxially grown on the SrTiO_3 (STO) (001) substrates by pulsed laser deposition (PLD) using a KrF excimer laser with a wavelength of 248 nm.6 The laser pulse frequency was 2 Hz and the energy density of laser pulse was ~2 J/cm^2. The temperature of substrate was kept at 700 °C, and the oxygen pressure was maintained at 0.3 mbar during the deposition. After the deposition, the LCMO films were in situ annealed in oxygen atmosphere with 1 atm pressure for 20 min. The crystallization of the LCMO films was examined by x-ray diffraction (XRD). The XRD results demonstrated that the films are in single phase with c-axis orientation. The sample was cut into 5 × 5 mm2 and 1.5 × 1.5 mm2 for the electrical and magnetic measurements, respectively. For electrical measurement, in order to obtain the Ohmic contact, four silver contact pads were prepared on LCMO films by thermal evaporation and the current leads were connected to the silver pads using supersonic wire bonder. The resistance of LCMO films was measured by standard four-probe method using a physical property measurement system (PPMS) with an optical window. The inset of Fig. 2(a) shows the schematic diagram of the measuring configuration with respect to the illuminated region. The direction of magnetic field was applied perpendicularly to the film surface (ab-plane). The dc magnetization measurements were carried out on a magnetic property measurement system (MPMS) using a fiber optic sample holder (FOSH) with the diameter of 1.6 mm, which allowed light can incident to the films directly through a fiber optic rod and bundle during the magnetic measurements. The light source used in the experiment was a He-Ne laser with the wavelength of 632.8 nm and the maximum power density of ~5 mW/cm^2.

Figure 1(a) shows the temperature dependence of resistances for LCMO films under various magnetic fields of 0, 1, 3, 5, 7, and 9 T measured in dark, respectively. At zero magnetic field, the resistances increase as the temperature decrease and undergo a sharp drop at T_C ~ 190 K, demonstrating an IM transition. As further increasing the magnetic...
field, the resistances decrease greatly in a broad range of temperature and the $T_C$ shifts to higher temperature. These are the typical colossal magnetoresistance (MR) characteristics of the doped manganites. The temperature dependence of MR (defined as $MR = [R(0) - R(H)]/R(0) \times 100\%$) under various magnetic fields is presented in Fig. 1(b). The peak of MR is clearly correlated with the IM transition temperature. The maximum MR are 60.2%, 90.9%, 95.7%, 97.3%, and 98% under the magnetic fields of 1, 3, 5, 7, and 9 T at 190 K, respectively. The temperature dependence of resistances for LCMO films is also measured under the irradiation of light without magnetic field. Figure 2(a) shows the temperature dependence of PR (defined as $PR = (R_{light} - R_{dark})/R_{dark} \times 100\%$) under the irradiation of light with different power density. The PR is negative when LCMO is in paramagnetic insulating (PMI) phase, and the PR turns to positive when LCMO is in ferromagnetic metallic (FMM) phase. As shown in Fig. 2(a), PR decreases from 6.1%, 4.6%, and 2.1% to 0.9% at 180 K, while PR increases from −0.76%, −0.53%, and −0.21%, to −0.08% at 215 K when the laser power density decreases from 5, 2.5, and 0.5 to 0.05 mW/cm², respectively. The positions of the minimum and maximum PR are almost fixed for the different laser power density. The phenomena can be understood as following: the transport of doped manganites is closely related to the spin of $e_g$ carriers and localized $t_{2g}$ spin core in Mn³⁺ and Mn⁴⁺ ions. In the PMI phase, the transport of LCMO can be described by small polaron hopping conduction model. The injection of photoexcited carriers can enhance the hopping of small polarons, leading to a decrease of resistance. In the FMM phase, light can stimulate electrons from localized $t_{2g}$ state to travelling $e_g$ state. As a result, the DE effect will be weakened, and the resistance of LCMO films will be increased. Figure 2(b) presents the temperature dependence of the magnetization with and without irradiation of light under a field of 1000 Oe measured in field-cooling (FC) and zero-field-cooling (ZFC) modes. The PM to FM transition temperature is at ~195 K, corresponding to the IM transition temperature. From the ZFC curves, one can see that the magnetic moment in ZFC with irradiation of light $M_{light}$ is smaller than that of in ZFC in dark $M_{dark}$ in FM phase. The temperature dependence of the photoinduced magnetization difference $\Delta M(T)$ (defined as $\Delta M(T) = M_{light}(T) - M_{dark}(T)$) is shown in the inset of Fig. 2(b). The $\Delta M(T)$ observed in the experiment may due to the weak light density of ~5 mW/cm². The decreasing of magnetization in FM phase indicates that the magnetic phase has been modified by the illumination due to the photoinduced demagnetization effect. The magnetic measurements give direct evidence that the photoexcited $e_g$ carriers suppress the spin correlation resulting in the decrease of the macroscopic magnetization. To test whether the photoinduced demagnetization effect in LCMO films can be influenced by magnetic fields, we further measured the resistance of LCMO under the magnetic field from 1 to 9 T with the irradiation of light. The difference of resistances measured in dark and the light illumination (referred to $R_{light}/R_{dark}$) under different magnetic fields is shown in the Fig. 3(a). The absolute value of
$R_{\text{light}} - R_{\text{dark}}$, no matter negative or positive it is, decreases greatly as magnetic fields are applied. The positions of the minimum and maximum values of $R_{\text{light}} - R_{\text{dark}}$ shift to higher temperature with further increasing the magnetic fields. Figure 3(b) shows the temperature dependence of the PR under various magnetic fields. The maximum PR are 6.1% at 180 K, 3.78% at 183 K, 2.57% at 190 K, 2.2% at 200 K, 1.81% at 210 K, and 1.3% at 215 K under the magnetic fields of 0, 1, 3, 5, 7, and 9 T, respectively. The maximum PR was reduced about five times when a magnetic field was introduced at low temperature. The inset of Fig. 3(b) shows the linearly growth of $T_C$ and the positive PR peaks with the increasing of temperature and the magnetic fields. As shown in the Fig. 3(c), the PR will decrease continually with the magnetic field increasing when measured at 180 K, where is in the FM phases. However, when measured at 210 K, the PR will increase at first from negative to positive as magnetic field increase from 0 to 5 T, then PR decrease with the magnetic field further increasing from 5 to 9 T. Different from the above results, the PR increase from the minimum value approaching zero with magnetic field increasing when measured at 300 K. The results reveal that the PR can be decreased by the magnetic field and the resistance tends to its original values of no light irradiation when measured at 300 K, where is in the FM phases. Therefore, applied magnetic fields will strongly affect the small polaron hoping energy in the PMI phase. The difference in the mobility of the initial (polaron) state and final (band) states should reduce as FMM phase in LCMO grows when magnetic fields increase. The localized small polaron in the PMI phase gradually transforms into an itinerant large polaron in the FMM phase. Therefore, the small polaron hoping energy of LCMO will gradually reduce as magnetic fields increase, resulting in the suppression of PR.

FIG. 3. (Color online) The temperature dependence of (a) $R_{\text{light}} - R_{\text{dark}}$ and (b) PR for LCMO film under various fields of 0, 1, 3, 5, 7, and 9 T, respectively. The arrows in (a) point out the positions of the maximum and minimum PR. The inset of (b) shows the field dependence of the metal-to-insulator transition temperatures $T_C$ and the temperatures at positive PR peaks. (c) The field dependence of PR measured in 180, 210, and 300 K, respectively.
the reduction of resistance changes. Therefore, in the FMM phase, the former factor is dominant, resulting in the decrease of PR. However, in the PMI phase, the latter factor will play a major role. Thus, the PR in LCMO film will increase with the magnetic field increasing.

To further confirm the erasure of PR by magnetic field, the similar experiment was carried out on the LCMO films grown on the LaAlO3 (LAO) substrate and the similar tendency of PR was observed. The resistance of LCMO films grown on LAO substrate is one degree of magnitude higher than that grown on STO substrate, and the IM transition temperature is about 200 K. Figure 4 shows the temperature dependence of $R_{\text{light}}-R_{\text{dark}}$ for LCMO films grown on LAO substrate under various fields of 0, 1, 3, 5, 7, and 9 T, respectively. Without the magnetic field, the maximum PR is 1.45% at 170 K and the minimum PR is −0.74% at 215 K, respectively. We find that the PR is also suppressed as magnetic fields increasing. The inset of Fig. 4 displays that the PR changes are 1.45% and 0.045% under 0 and 9 T at 170 K, respectively. The maximum PR is reduced over thirty times when magnetic fields increase from 0 to 9 T at 170 K. It is noted that the PR of LCMO films grown on LAO substrates is relative lower than that grown on STO substrates. Here, the strain effect induced by the different substrates should take into account. According to the XRD results, an in-plane tensile strain will be introduced in the LCMO film due to the lattice mismatch of 0.72% between STO substrate and LCMO film. While, a larger compressive in-plane strain is achieved due to the larger lattice mismatch of −3.42% between LAO substrate and LCMO film. As discussed in our previous works, the reduction of in-plane strain of LCMO will influence the J-T distortion of MnO$_6$ octahedral and further weaken the electron-lattice coupling. Therefore, a smaller strain will result in a reduction of the separation between upper $t_{2g}$ and lower $e_g$ levels, and the observed larger PR in LCMO films grown on STO substrate is understandable. In addition, as mentioned above, magnetic domains will be reoriented under external magnetic fields. It is well known that the domain characteristics are strongly dependent on the film thickness. Bakaul et al. found that thinner La$_{0.7}$Sr$_{0.3}$MnO$_3$ films exhibit long and continuous stripe-like domains, whereas the domains in the thicker samples (over 135 nm) will break up to bubble-like entities. The effects of magnetic fields to the different domain features are thought to be distinct; thus, the degree of suppression of PR in manganite films with various thicknesses may make a difference. In our work, LCMO films with thickness of ~150 nm may only cover one situation here. Further studies on the different domain characteristics to the suppression of PR are under way.

The PR observed in our work is much smaller than what was reported by Moshnyaga et al. due to the weak light density of ~5 mW/cm$^2$. In the Ref. 12, an Al$_2$O$_3$:Ti pulsed laser with power of 1 W and focused spot of about 50 μm was used as light source. The power density of them is much higher than our He-Ne laser. Therefore, a giant negative photocconductivity in La$_{0.7}$Ca$_{0.3}$MnO$_3$ thin film can be observed. Recently, Smolyaninova et al. reported that large photoinduced conductivity reduction in manganite films using a continuous wave argon ion laser with power density of ~31.8 mW/cm$^2$. The relative change of film resistance is about 3% at 110 K, which is comparable with our work. The little differences may be caused by the defects or carrier density of different manganite films. Furthermore, one might suspect that the transition was driven by the laser heating. However, we did not observe any PR or the decrease of magnetization when the LCMO film was irradiated by a 1.55 μm semiconductor laser with the power density of 15 mW/cm$^2$. Since the photon energy (~0.8 eV) is smaller than the band gap of LCMO (~1 eV), and no photoexcited carriers can be generated. The results demonstrate that the PR behavior in our case is induced by its intrinsic property of manganites instead of heating effect.

In conclusion, we performed systematic studies on the effects of magnetic field on the photoinduced demagnetization effect in LCMO films. We observed that the photoinduced demagnetization effect is weakened by the magnetic field in LCMO thin films. In the FMM phase, the decrease of magnetization was observed under light illumination, indicating that the photo-excitation of spin polarized electrons from the localized $t_{2g}$ state to the travelling $e_g$ state can decrease the magnetization of LCMO thin films. It has been also found that the PR can be decreased by external magnetic field. This behavior can be explained by the following two effects: (i) the reorientation of the FMM domains and spin direction of photoexcited carriers in LCMO films and (ii) the release and recombination of electrons trapped around oxygen vacancies under magnetic field. Our results indicate the results of magnetic field can weaken the effects of injection of photoexcited $e_g$ carriers in manganites and make the resistance return to its original values of no light irradiation. It provides us some insight into the nature of physical mechanism of manganites under irradiation of light. The interplay of the external fields is a good demonstration of the strong coupling between spins and charges in such colossal magnetoresistance materials. From the view of potential application, this may be useful in developing practical magnetically tunable photosensors or magneto-optical recording devices.

FIG. 4. (Color online) The temperature dependence of $R_{\text{light}}-R_{\text{dark}}$ for LCMO films grown on LAO substrate under various fields of 0, 1, 3, 5, 7, and 9 T, respectively. The inset shows the field dependence of the PR measured in 170 K.

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